Power MOSFET

30 V, 106 A, Single N-Channel, SO-8 FL

Features

- Integrated Schottky Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- Synchronous Rectification for DC–DC Converters
- Low Side Switching
- Telecom Secondary Side Rectification

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Para	Parameter			Value	Unit
Drain-to-Source Volt	age		V_{DSS}	30	V
Gate-to-Source Volta	Gate-to-Source Voltage			±20	V
Continuous Drain		T _A = 25°C	Ι _D	30	Α
Current R _{θJA} (Note 1)		T _A = 85°C		22	
Power Dissipation R _{0JA} (Note 1)		T _A = 25°C	P _D	3.13	W
Continuous Drain		T _A = 25°C	Ι _D	48	Α
Current R _{θJA} ≤ 10 sec		T _A = 85°C		34	
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P_{D}	7.7	W
Continuous Drain Current R _{0.1A}	State	$T_A = 25^{\circ}C$	Ι _D	22	Α
(Note 2)		T _A = 85°C		16	
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	1.7	W
Continuous Drain		T _C = 25°C	Ι _D	106	Α
Current R _{θJC} (Note 1)		T _C = 85°C		76	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P_{D}	38	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	320	Α
Current limited by pac	ckage	$T_A = 25^{\circ}C$	I _{Dmaxpkg}	100	Α
Operating Junction ar Temperature	Operating Junction and Storage		T _J , T _{STG}	-55 to +150	°C
Source Current (Body	Source Current (Body Diode)			54	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain–to–Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_{L} = 45 A _{pk} , L = 0.1 mH, R _G = 25 Ω)			EAS	101	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

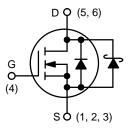


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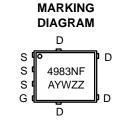
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	2.1 mΩ @ 10 V	106 A
	3.1 mΩ @ 4.5 V	106 A

N-CHANNEL MOSFET







A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4983NFT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4983NFT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	3.3	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	40	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	74	*C/vv
Junction–to–Ambient – t ≤ 10 sec	$R_{ heta JA}$	16.3	

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS					1	1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1.0 \text{ mA}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 10 mA, referenced to 25°C			15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 1.0 mA	1.2	1.7	2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 10 mA, referen	nced to 25°C		5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		1.6	2.1	
			I _D = 15 A		1.6		
	V _{GS} = 4.5	V _{GS} = 4.5 V	I _D = 30 A		2.5	3.1	mΩ
			I _D = 15 A		2.5		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			60		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			3250		pF
Output Capacitance	C _{OSS}				1340		
Reverse Transfer Capacitance	C _{RSS}				90		
Total Gate Charge	$Q_{G(TOT)}$				22.6		
Threshold Gate Charge	Q _{G(TH)}	V 45VV	15 \/. 1 20 A		2.9] "
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			7.0		nC
Gate-to-Drain Charge	Q_{GD}				6.9		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 30 \text{ A}$			47.9		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			13.5		
Rise Time	t _r				24.9		1
Turn-Off Delay Time	t _{d(OFF)}				28.7		ns
Fall Time	t _f				10.7		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 3. Pulse Test: pulse width $\leq 300 \,\mu s$, duty cycle $\leq 2\%$.
- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

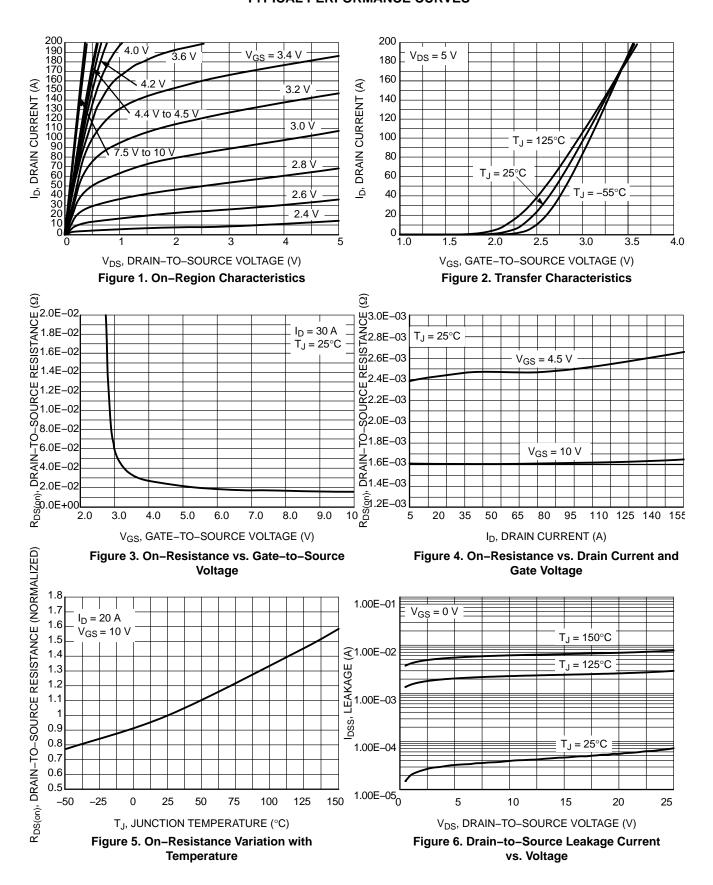
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9.4		
Rise Time	t _r				16.7		
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 A, R_G$	= 3.0 Ω		35.2		ns
Fall Time	t _f	1			7.4		1
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V_{SD}	VGS = 0 V,	T _J = 25°C		0.4	0.7	
			T _J = 125°C		0.32		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 2 \text{ A}$			45		
Charge Time	t _a				23		ns
Discharge Time	t _b				22		
Reverse Recovery Charge	Q_{RR}				50		nC
PACKAGE PARASITIC VALUES				-			
Source Inductance	L _S	T _A = 25°C			0.65		nΗ
Drain Inductance	L _D				0.20		
Gate Inductance	L _G				1.5		
Gate Resistance	R_{G}				1.0		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

6

5 4

3 2

1

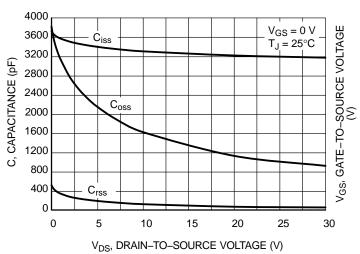


Figure 7. Capacitance Variation

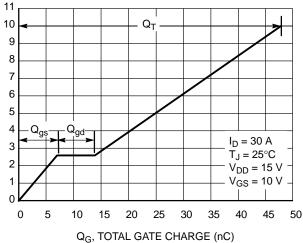


Figure 8. Gate-to-Source and

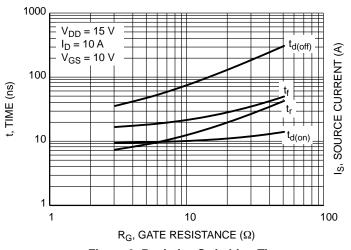


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Drain-to-Source Voltage vs. Total Charge 10 9 $V_{GS} = 0 V$ $T_J = 25^{\circ}C$ 8 7

0 0.1 0.0 0.2 0.3 0.4 0.5 V_{SD}, SOURCE-TO-DRAIN VOLTAGE (V)

Figure 10. Diode Forward Voltage vs. Current

0.7

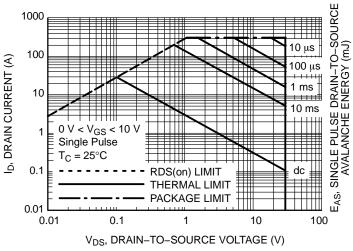
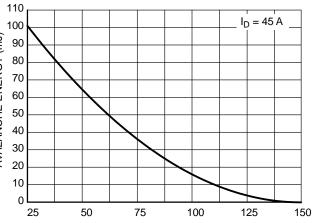


Figure 11. Maximum Rated Forward Biased Safe Operating Area



T_J, STARTING JUNCTION TEMPERATURE (°C)

Figure 12. Maximum Avalanche Energy vs. **Starting Junction Temperature**

TYPICAL PERFORMANCE CURVES

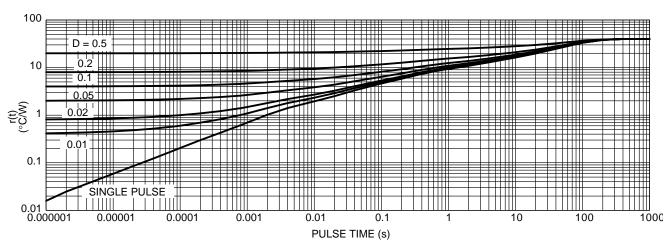
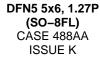
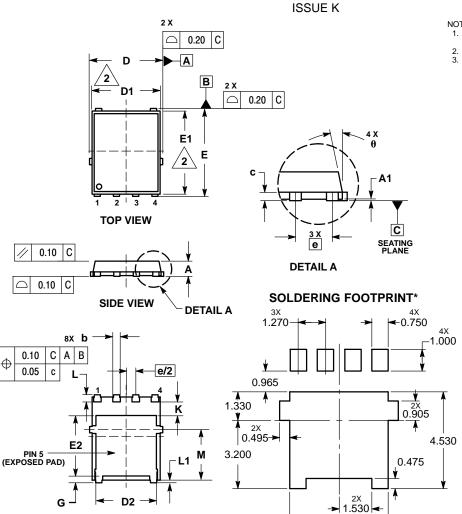


Figure 13. Thermal Response

PACKAGE DIMENSIONS





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC				
G	0.51	0.61	0.71			
K	1.20	1.35	1.50			
L	0.51	0.61	0.71			
L1	0.125 REF					
M	3.00	3.40	3.80			
θ	0 °		12 °			

- STYLE 1: PIN 1. SOURCE 2. SOURCE 3. SOURCE

 - GATE DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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